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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  Date Submitted: August 22, 2006  <i>(use as many sheets as necessary)</i>				Application Number	10/585,576
				Filing Date	12/28/2004
				First Named Inventor	Kazuya UEJIMA 4136
				Group Art Unit	Unassigned
				Examiner Name	Unassigned Duy T Nguyen
Attorney Docket Number	065686-0163				
Sheet	1	of	1		

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code <sup>2</sup> (if known)			

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FOREIGN PATENT DOCUMENTS								
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/D.N./	B1	Applied Physics, Vol. 65, No. 11, pp. 1131-1134, 1996.		
/D.N./	B2	M. TAMURA et al., "Secondary Defects in 1-10 keV As- and BF2-implanted Si," International Conference on Ion Implantation Technology Proceedings, pp. 744-747, 1999.		

Examiner Signature	/Duy Nguyen/	Date Considered	10/29/2008
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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